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ADVANCED  
LINEAR  
DEVICES, INC.

ALD2331A/ALD2331B/ALD2331

## DUAL PRECISION CMOS VOLTAGE COMPARATOR WITH OPEN DRAIN OUTPUT DRIVER

### GENERAL DESCRIPTION

The ALD2331A/ALD2331B/ALD2331 is a monolithic high performance dual precision voltage comparator built with advanced silicon gate EPAD® CMOS technology intended for high precision analog applications. The ALD2331A/ALD2331B/ALD2331 offers ultra-low input offset voltages and currents at its input pre-amplifier, precision voltage comparator and high-current output driver integrated on-chip, in one industry standard pinout 8 Lead PDIP or SOIC package. Primary features include: very high typical input impedance of  $10^{12}\Omega$ ; low input bias current of 10pA; fast response time of 750ns with only 10mV input step signal; very low power dissipation of 55 $\mu$ A per comparator; and single (+5V) or dual ( $\pm$ 5V) power supply operation; and 50mA open drain output drivers.

The input voltage range includes ground, making this comparator ideal for low level signal detection with high source impedance. The outputs are open-drain configurations, allowing maximum application flexibility, such as wired-OR connection and various different output loads. An external pull-up resistor is required for each output, although the value of the pull-up resistor can vary over a wide range in order to suit the application needs. The outputs can be connected to a higher external voltage than V<sup>+</sup>.

The ALD2331A/ALD2331B/ALD2331 is ideal for a great variety of precision analog voltage comparator applications, especially low level signal detection circuits requiring low standby power, yet retaining high output current capability as needed.

### FEATURES

- Fanout of 30LS TTL loads
- Guaranteed to drive 200 $\Omega$  loads
- Low supply current of 55 $\mu$ A typical
- Pinout of LM193 industry standard voltage comparators
- Extremely low input bias currents -- typically 10pA
- Virtually eliminates source impedance effects
- Low operating supply voltage of 3V to 10V
- Single (+5V) and dual supply ( $\pm$ 5V) operation
- High speed for both large and small level signals -- 300ns typical for TTL inputs
- CMOS, NMOS and TTL compatible
- Wired-OR open drain outputs
- High output sink current -- typically 50mA
- Low supply current spike

### ORDERING INFORMATION ("L" suffix for lead free version)

Operating Temperature Range *	
0°C to +70°C	0°C to +70°C
8-Pin Small Outline Package (SOIC)	8-Pin Plastic Dip Package
ALD2331ASAL	ALD2331APAL
ALD2331BSAL	ALD2331BPAL
ALD2331SAL	ALD2331PAL

\* Contact factory for leaded (non-RoHS) or high temperature versions.

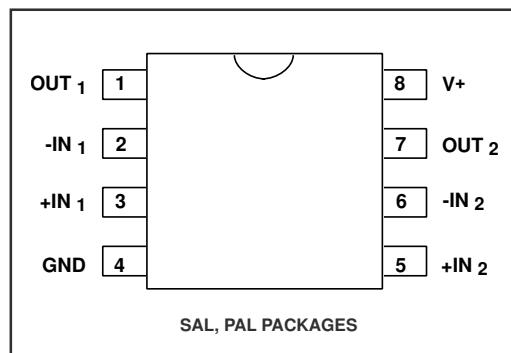
### APPLICATIONS

- Simple precision reference voltage setting
- High source impedance voltage comparison circuits
- MOSFET driver
- Dual limit window comparator
- Power supply voltage monitor
- Photo-detector sensor circuit
- Relay or LED driver
- Oscillators
- Battery operated instruments
- Remote signal detection

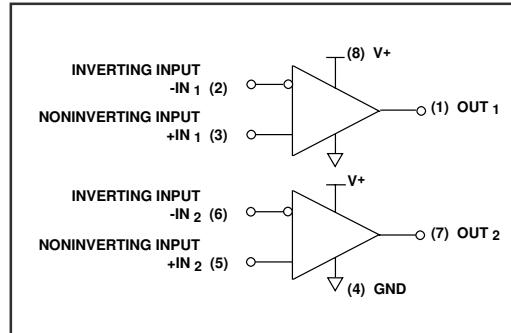
### BENEFITS

- Simple precision reference voltage setting
- On-chip input pre-amplifier and output buffers
- Precision voltage comparison without pre-amplifier
- Eliminates need for second power supply
- Wide range of pull-up resistor values

### PIN CONFIGURATION



### BLOCK DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

Supply voltage, V+		+10.6V
Differential input voltage range		-0.3V to V+ +0.3V
Power dissipation		600 mW
Operating temperature range SAL, PAL packages		0°C to +70°C
Storage temperature range		-65°C to +150°C
Lead temperature, 10 seconds		+260°C

## OPERATING ELECTRICAL CHARACTERISTICS

TA = 25°C V+ = +5V unless otherwise specified

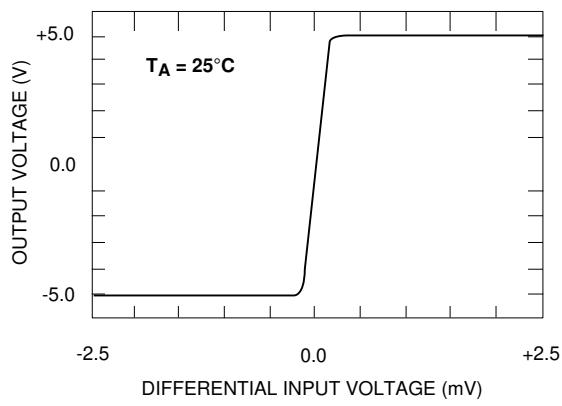
Parameter	Symbol	2331A			2331B			2331			Unit	Test Conditions
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max		
Supply Voltage	V <sub>S</sub> V <sub>+</sub>	±1.5 3		±5 10	±1.5 3		±5 10	±1.5 3		±5 10	V V	Dual Supply Single Supply
Supply Current	I <sub>S</sub>		110	180		110	180		110	180	µA	No Load Two Comparators
Voltage Gain	AVD	50	150		50	150		50	150		V/mV	R <sub>LOAD</sub> ≥ 15K
Input Offset Voltage	V <sub>O</sub> S		0.2	0.5		0.5	1.0		1.0	2.0	mV	R <sub>LOAD</sub> ≥ 1.5KΩ
Input Offset Current <sup>1</sup>	I <sub>O</sub> S		0.01	20		0.01	20		0.01	20	pA	
Input Bias Current <sup>1</sup>	I <sub>B</sub>		0.01	20		0.01	20		0.01	20	pA	
Common Mode Input Voltage Range <sup>2</sup>	V <sub>ICR</sub>	-0.3		V <sub>+</sub> -1.5	-0.3		V <sub>+</sub> -1.5	-0.3		V <sub>+</sub> -1.5	V	
Low Level Sink Output Voltage	V <sub>O</sub> L		0.15	0.4		0.15	0.4		0.15	0.4	V	I <sub>SINK</sub> = 12mA V <sub>INPUT</sub> = 1V Differential
Low Level Sink Output Current	I <sub>O</sub> L	24	50		24	50		24	50		mA	V <sub>O</sub> L = 1.0 V SINK OUTPUT ON
High Level Sink Output Leakage Current	I <sub>L</sub>		0.01	20		0.01	20		0.01	20	nA	V <sub>OUT</sub> = 5.0 V SINK OUTPUT OFF
Response Time <sup>2</sup>	t <sub>RP</sub>		1.1		1.1			1.1			µs	R <sub>L</sub> = 5.1KΩ, C <sub>L</sub> = 15pF 5mV Input Step/ 5mV Overdrive
	t <sub>RP</sub>		2.4		2.4			2.4			µs	R <sub>L</sub> = 5.1KΩ, C <sub>L</sub> = 15pF 1mV Input Step/ 1mV Overdrive
	t <sub>RP</sub>		600		600			600			ns	R <sub>L</sub> = 5.1KΩ, C <sub>L</sub> = 15pF 100mV Input Step/ 5mV Overdrive
	t <sub>RP</sub>		300		300			300			ns	R <sub>L</sub> = 5.1KΩ, C <sub>L</sub> = 15pF TTL level Input Step
Common Mode Rejection Ratio	CMRR		80		80			80			dB	V <sub>INPUT</sub> = 0V to 2.5V
Power Supply Rejection Ratio	PSRR		75		75			75			dB	V <sub>+</sub> = 4V to 5V

Notes: <sup>1</sup> Consists of junction leakage currents

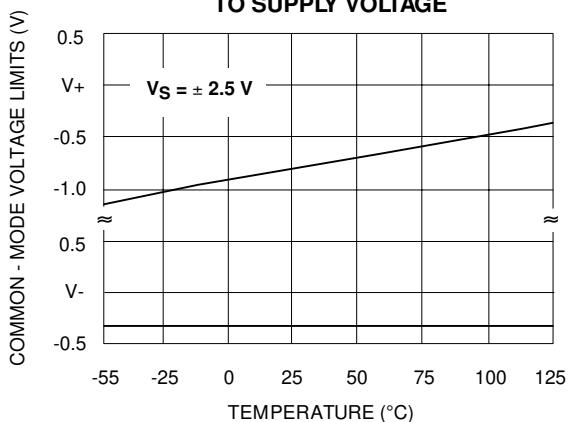
<sup>2</sup> Sample test parameter

## TYPICAL PERFORMANCE CHARACTERISTICS

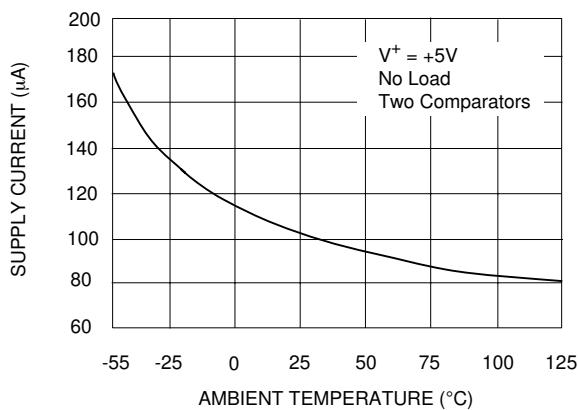
**TRANSFER FUNCTION**



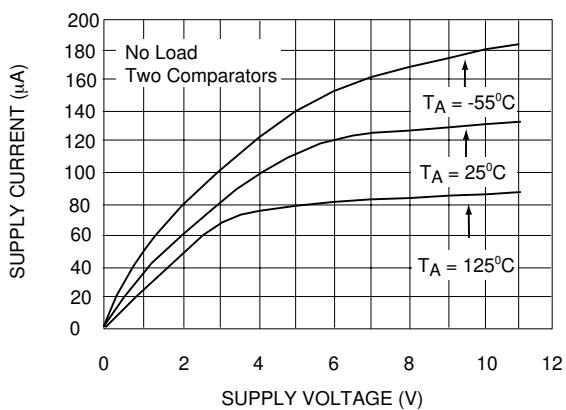
**COMMON - MODE VOLTAGE REFERRED TO SUPPLY VOLTAGE**



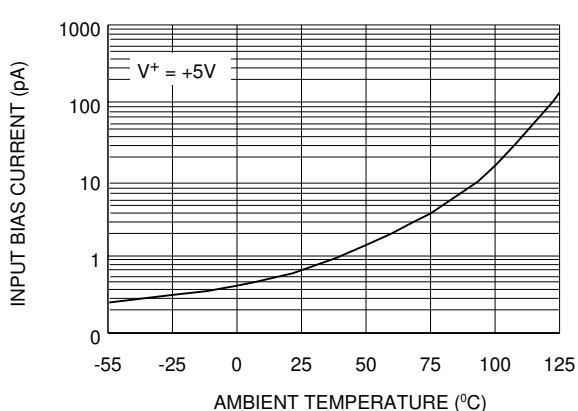
**SUPPLY CURRENT vs.TEMPERATURE**



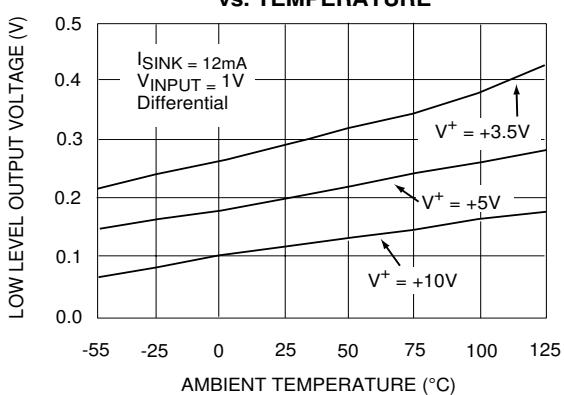
**SUPPLY CURRENT vs. SUPPLY VOLTAGE**



**INPUT BIAS CURRENT vs. TEMPERATURE**

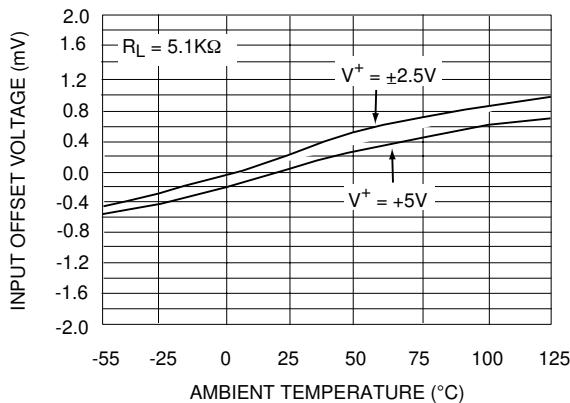


**LOW LEVEL OUTPUT VOLTAGE vs. TEMPERATURE**

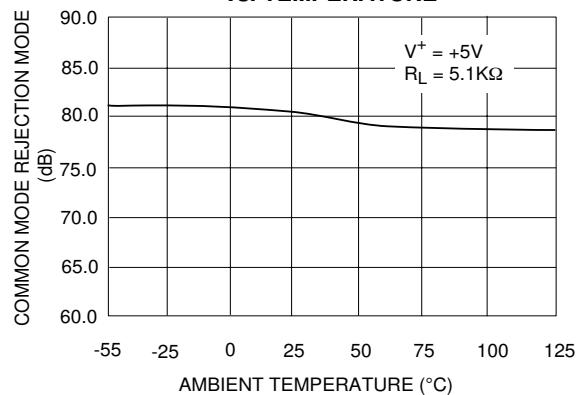


## TYPICAL PERFORMANCE CHARACTERISTICS (cont'd)

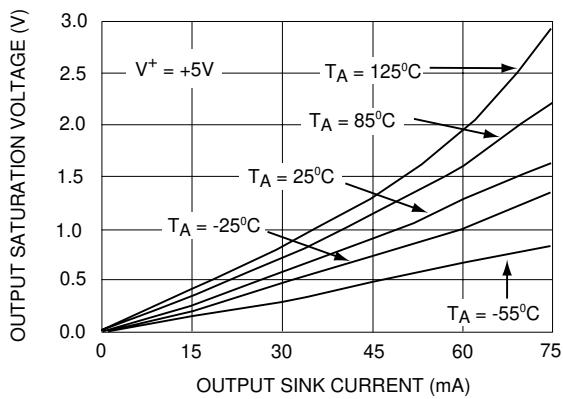
**INPUT OFFSET VOLTAGE vs. TEMPERATURE**



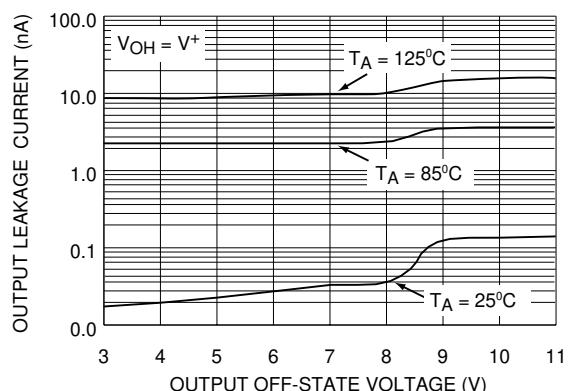
**COMMON MODE REJECTION RATIO vs. TEMPERATURE**



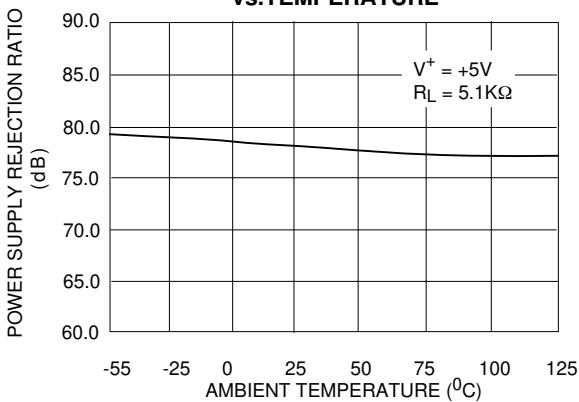
**SATURATION VOLTAGE vs. SINK CURRENT**



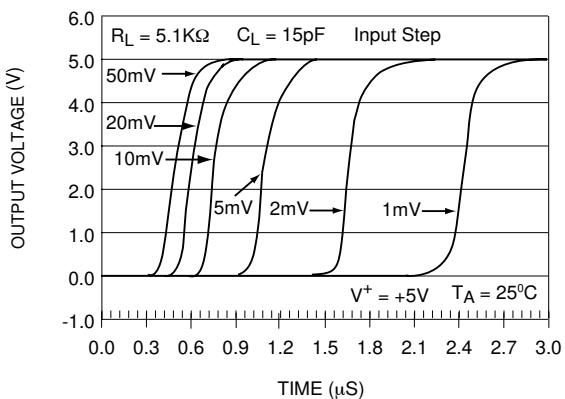
**OUTPUT OFF-STATE VOLTAGE vs. OUTPUT LEAKAGE CURRENT**



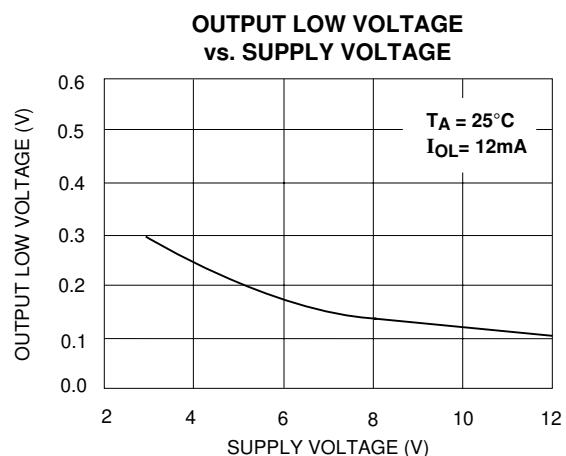
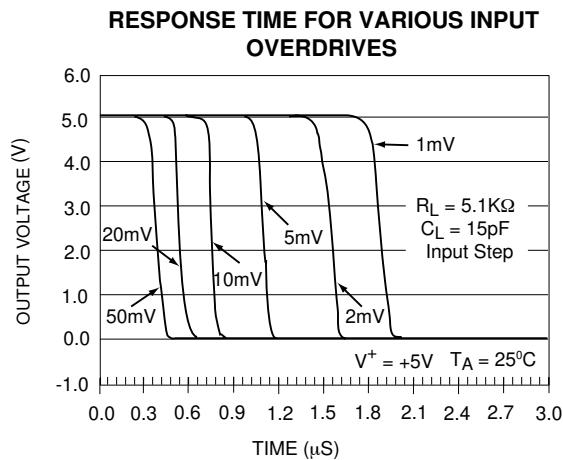
**POWER SUPPLY REJECTION RATIO vs. TEMPERATURE**



**RESPONSE TIME FOR VARIOUS INPUT OVERDRIVES**

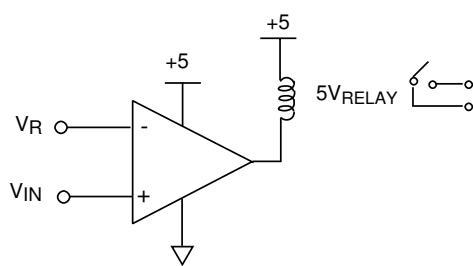


## TYPICAL PERFORMANCE CHARACTERISTICS (cont'd)

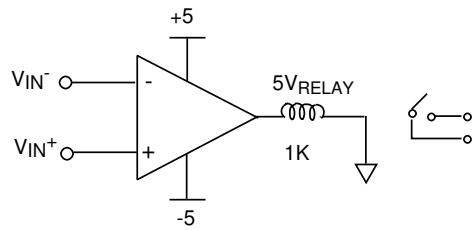


## TYPICAL APPLICATIONS

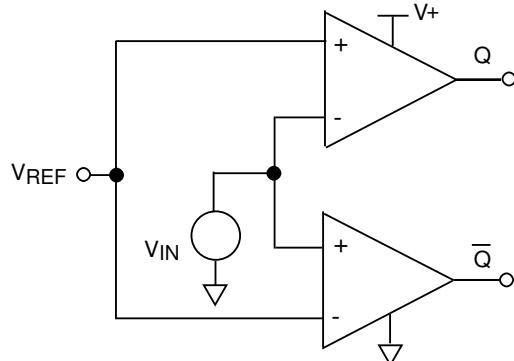
**PRECISION SINGLE SUPPLY VOLTAGE COMPARATOR WITH DIRECT RELAY DRIVER**



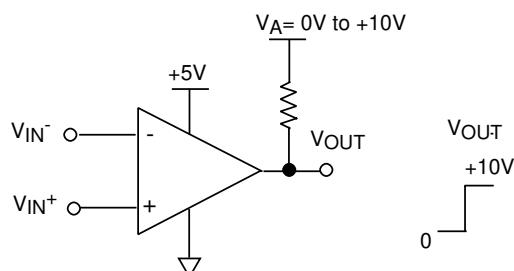
**VOLTAGE COMPARATOR WITH +/-5V SUPPLY AND +5V RELAY DRIVE**



**VOLTAGE COMPARATOR WITH COMPLEMENTARY OUTPUTS**

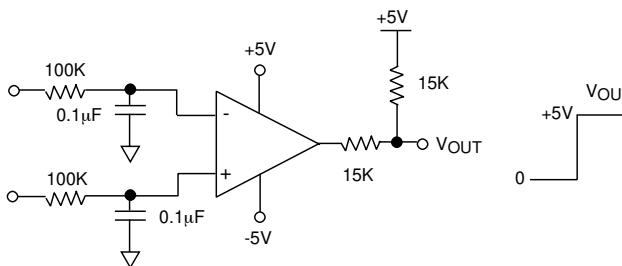


**VOLTAGE COMPARATOR WITH SINGLE SUPPLY AND OUTPUT LEVEL SHIFT**

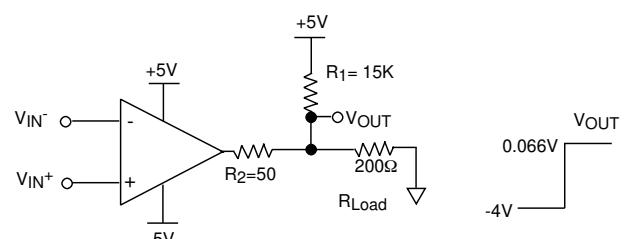


## TYPICAL APPLICATIONS (cont'd)

**VOLTAGE COMPARATOR WITH +/-5V SUPPLY AND OUTPUT LEVEL SHIFT**

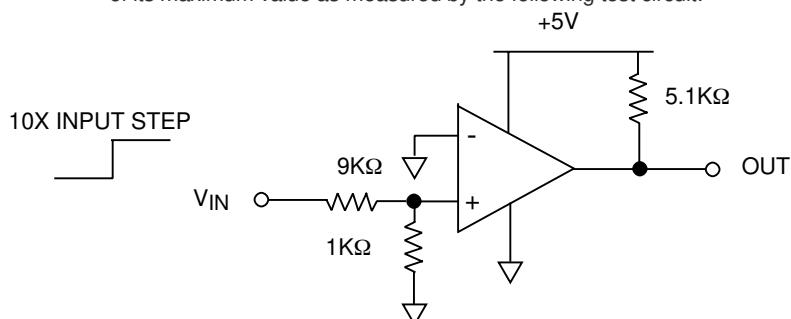


**VOLTAGE COMPARATOR WITH OUTPUT LEVEL SHIFT AND HIGH CURRENT LOAD DRIVER**

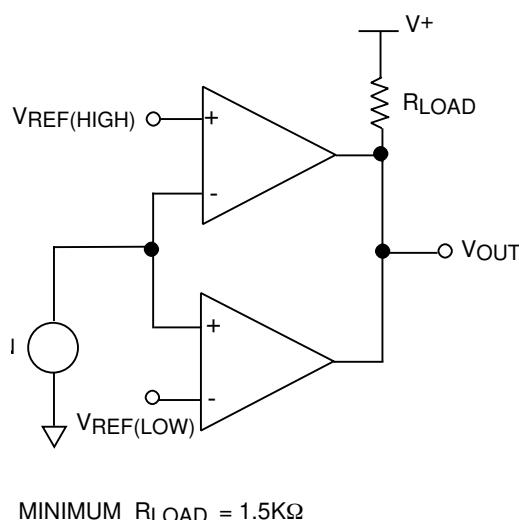


**RESPONSE TIME MEASUREMENT CIRCUIT**

Response time is defined as the interval between the application of an input step function and the instant when the output reaches 50% of its maximum value as measured by the following test circuit:



**DUAL LIMIT WINDOW COMPARATOR**

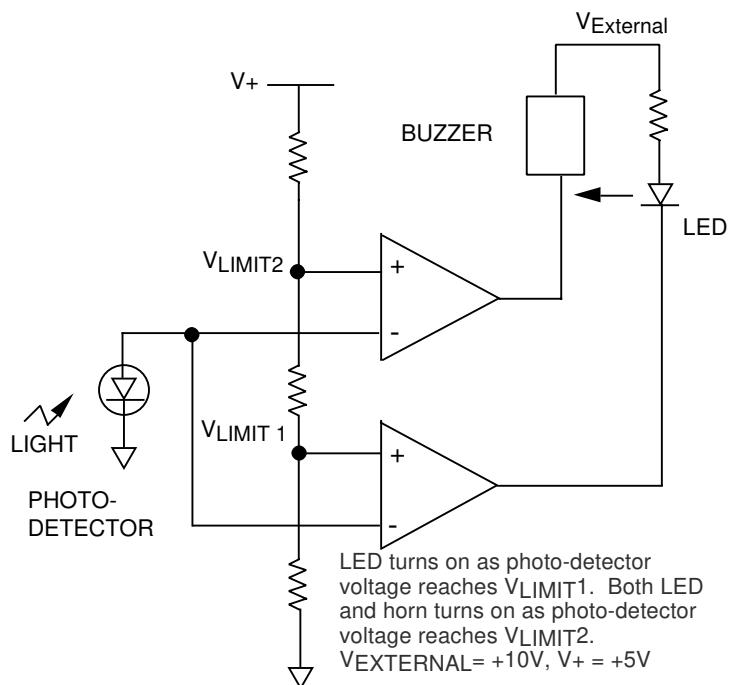


MINIMUM  $R_{LOAD} = 1.5\text{ k}\Omega$

OUTPUT HIGH FOR  $V_{IN} < V_{REF(HIGH)}$

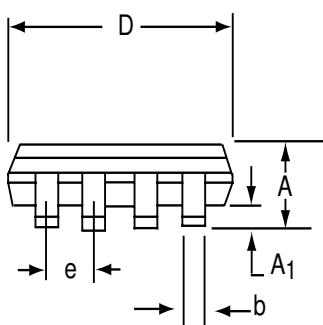
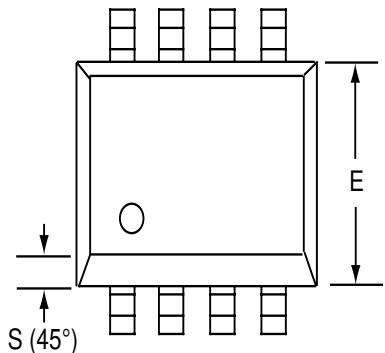
AND  $V_{IN} > V_{REF(LOW)}$

**DUAL LIMIT PHOTO DETECTOR MONITOR**

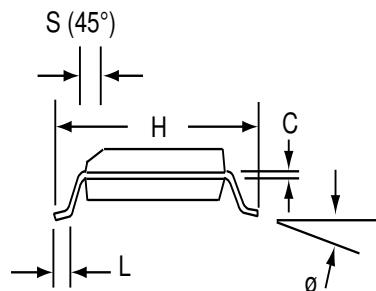


## SOIC-8 PACKAGE DRAWING

**8 Pin Plastic SOIC Package**

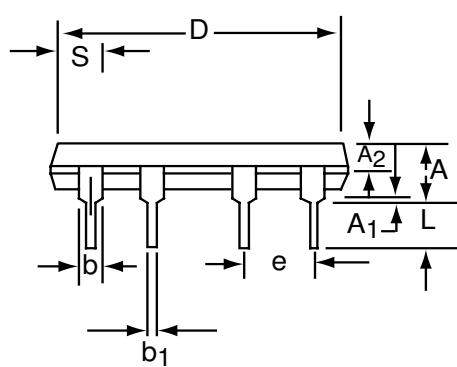
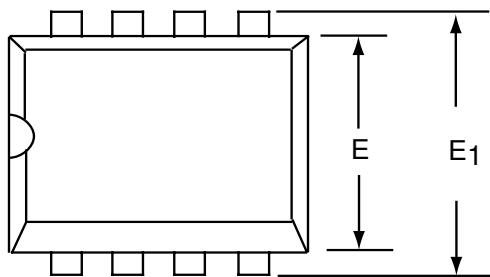


Dim	Millimeters		Inches	
	Min	Max	Min	Max
<b>A</b>	1.35	1.75	0.053	0.069
<b>A<sub>1</sub></b>	0.10	0.25	0.004	0.010
<b>b</b>	0.35	0.45	0.014	0.018
<b>C</b>	0.18	0.25	0.007	0.010
<b>D-8</b>	4.69	5.00	0.185	0.196
<b>E</b>	3.50	4.05	0.140	0.160
<b>e</b>	1.27 BSC		0.050 BSC	
<b>H</b>	5.70	6.30	0.224	0.248
<b>L</b>	0.60	0.937	0.024	0.037
<b>Ø</b>	0°	8°	0°	8°
<b>S</b>	0.25	0.50	0.010	0.020



## PDIP-8 PACKAGE DRAWING

**8 Pin Plastic DIP Package**



Dim	Millimeters		Inches	
	Min	Max	Min	Max
<b>A</b>	3.81	5.08	0.105	0.200
<b>A<sub>1</sub></b>	0.38	1.27	0.015	0.050
<b>A<sub>2</sub></b>	1.27	2.03	0.050	0.080
<b>b</b>	0.89	1.65	0.035	0.065
<b>b<sub>1</sub></b>	0.38	0.51	0.015	0.020
<b>c</b>	0.20	0.30	0.008	0.012
<b>D-8</b>	9.40	11.68	0.370	0.460
<b>E</b>	5.59	7.11	0.220	0.280
<b>E<sub>1</sub></b>	7.62	8.26	0.300	0.325
<b>e</b>	2.29	2.79	0.090	0.110
<b>e<sub>1</sub></b>	7.37	7.87	0.290	0.310
<b>L</b>	2.79	3.81	0.110	0.150
<b>S-8</b>	1.02	2.03	0.040	0.080
<b>Ø</b>	0°	15°	0°	15°

